


<b>Search Notes</b>  	<b>Application/Control No.</b>  10564491	<b>Applicant(s)/Patent Under Reexamination</b>  DEGEL ET AL.
	<b>Examiner</b>  Dwan A Gerido, Ph.D.	<b>Art Unit</b>  1797

SEARCHED			
Class	Subclass	Date	Examiner
422	101, 102	10/26/2008	DAG
435	305.1	10/26/2008	DAG
206	503, 512	10/26/2008	DAG

SEARCH NOTES		
Search Notes	Date	Examiner
Search edited by text	10/26/2008	DAG

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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